

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Shi, et al.

Title: **SYSTEM AND SOFTWARE FOR DATA COLLECTION AND
PROCESS CONTROL IN SEMICONDUCTOR MANUFACTURING
AND METHOD THEREOF**

Application No.: 09/905,220 Filed: July 12, 2001

Examiner: Alexander J. Kosowski Group Art Unit: 2125

Atty. Docket No.: 1458.TT4869 NOA Date: n/a

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SUBMISSION OF NEW FORMAL DRAWINGS

Transmitted herewith are twenty-two (22) sheets of new formal drawings containing
Figs. 1; 2; 3; 4A & 4B; 5A & 5B; 6-20, respectively.

The new drawings correct informalities.

Respectfully submitted,

7-23-03
Date

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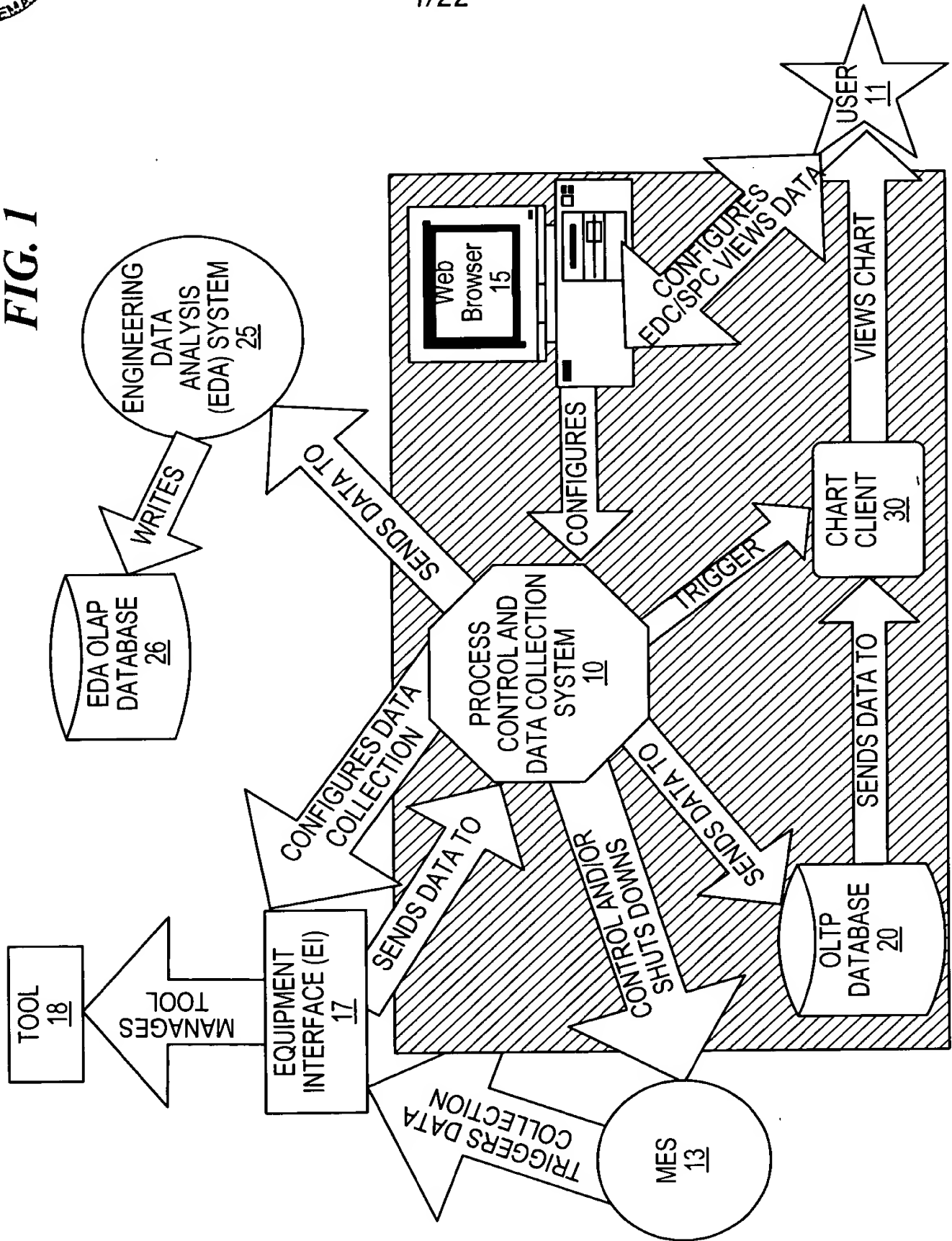
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FIG. 1



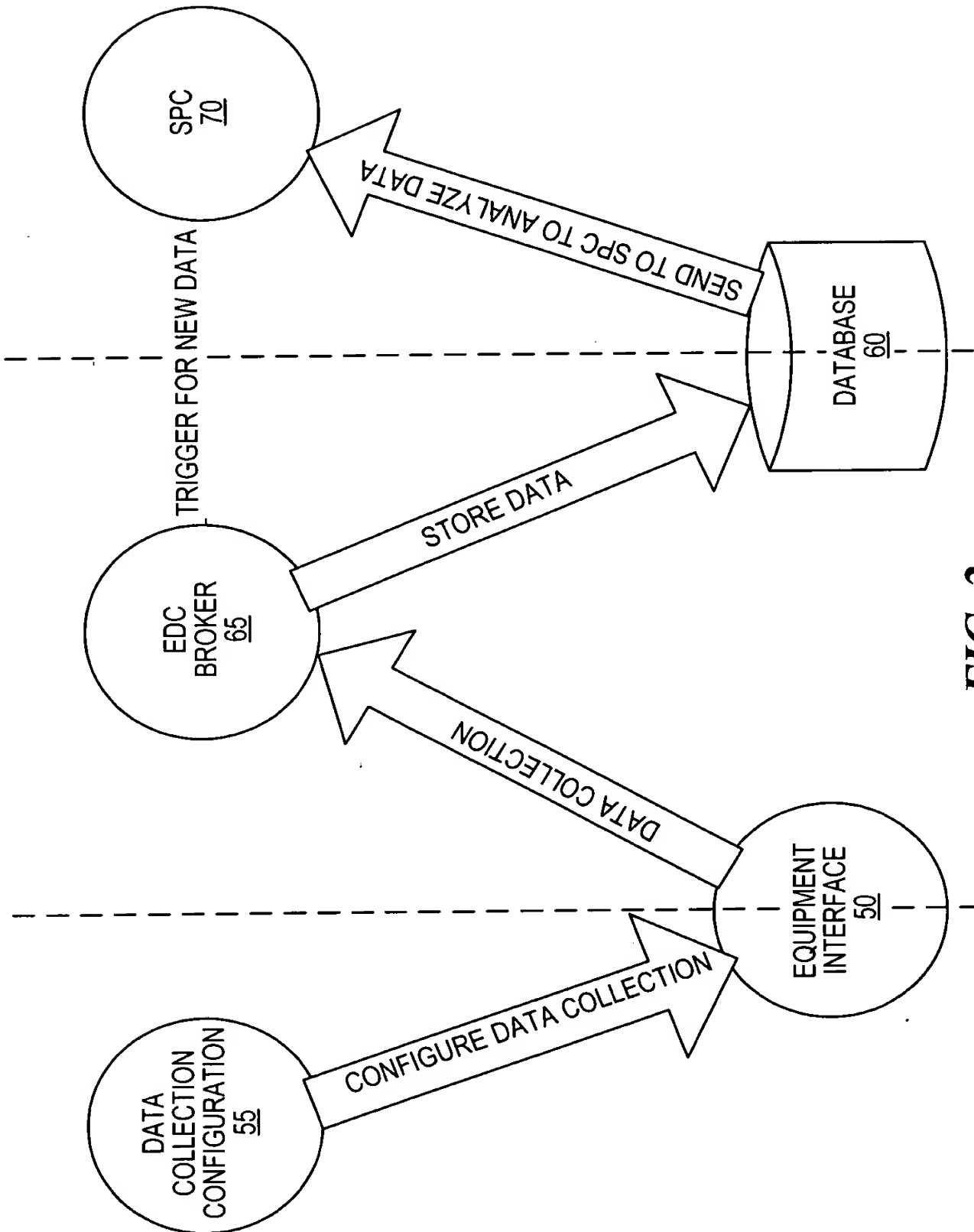
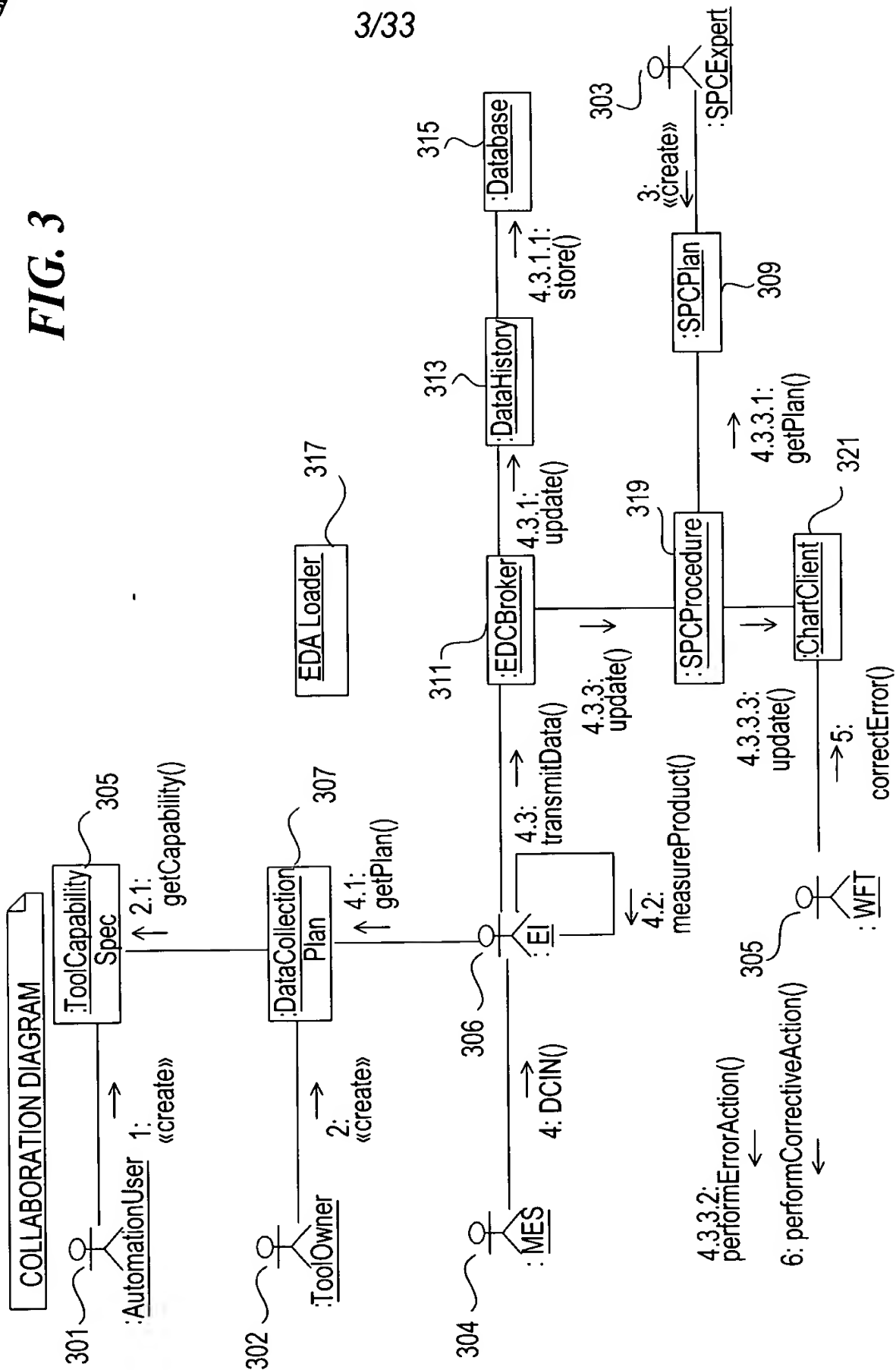


FIG. 2

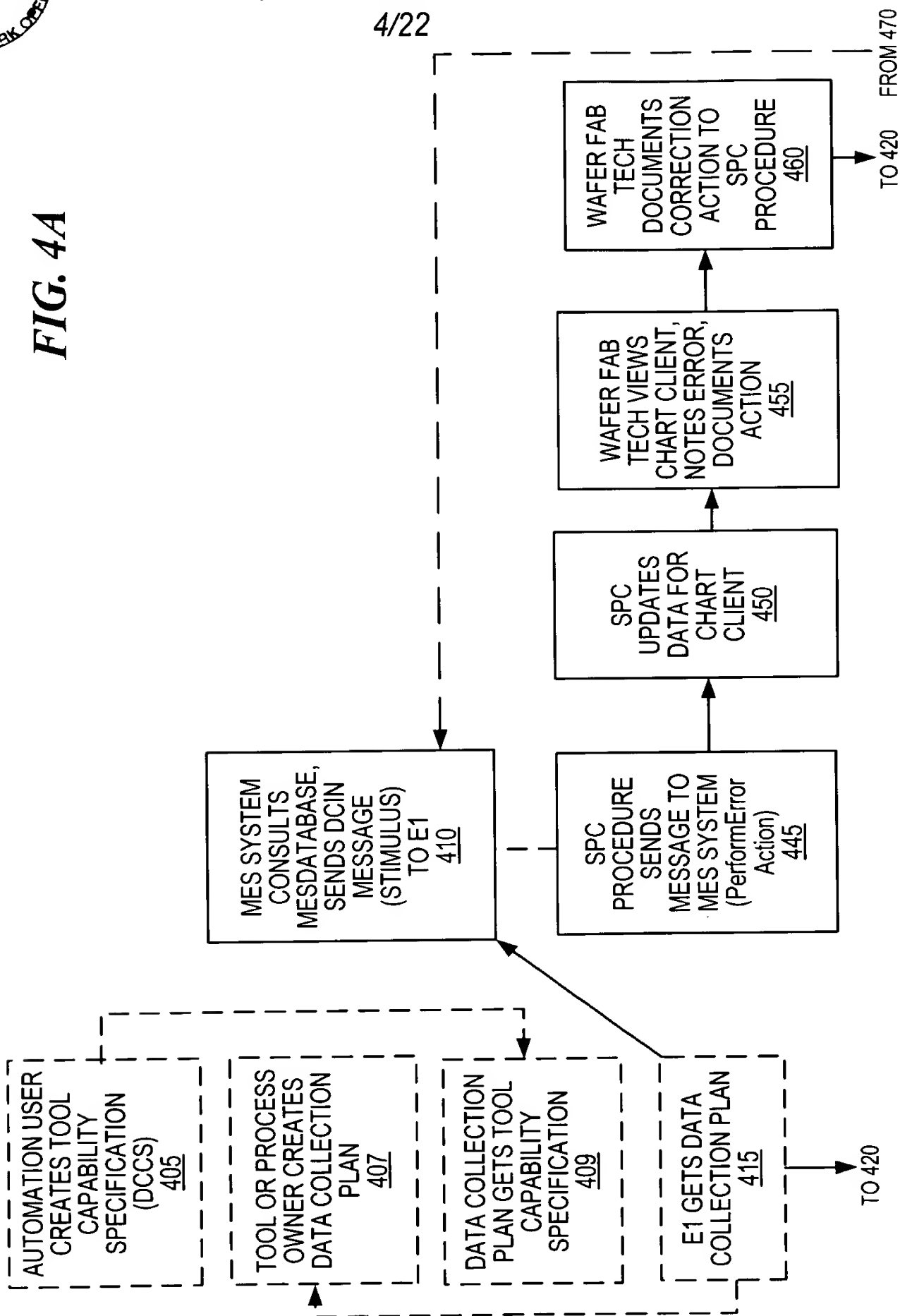
FIG. 3





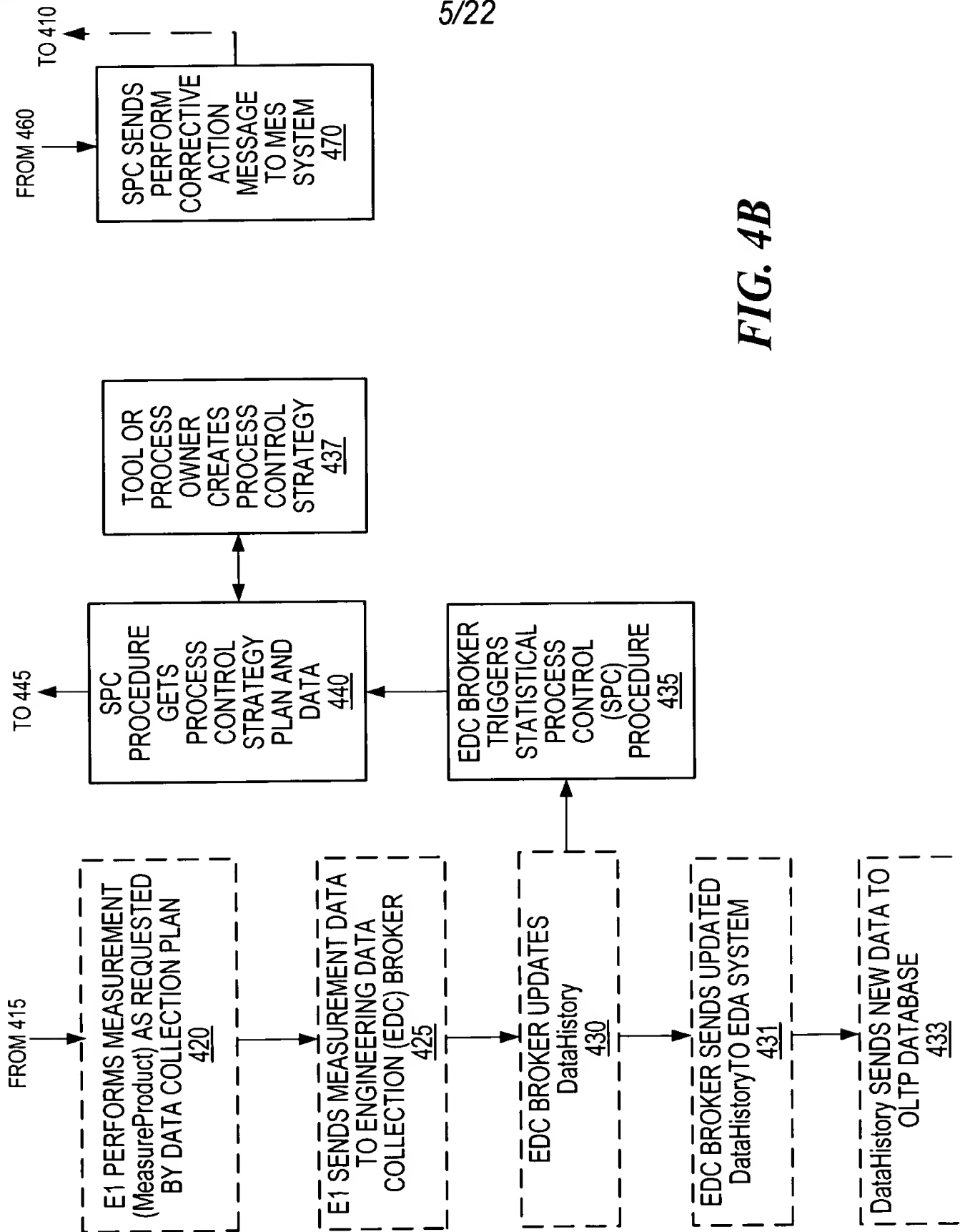
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FIG. 4A





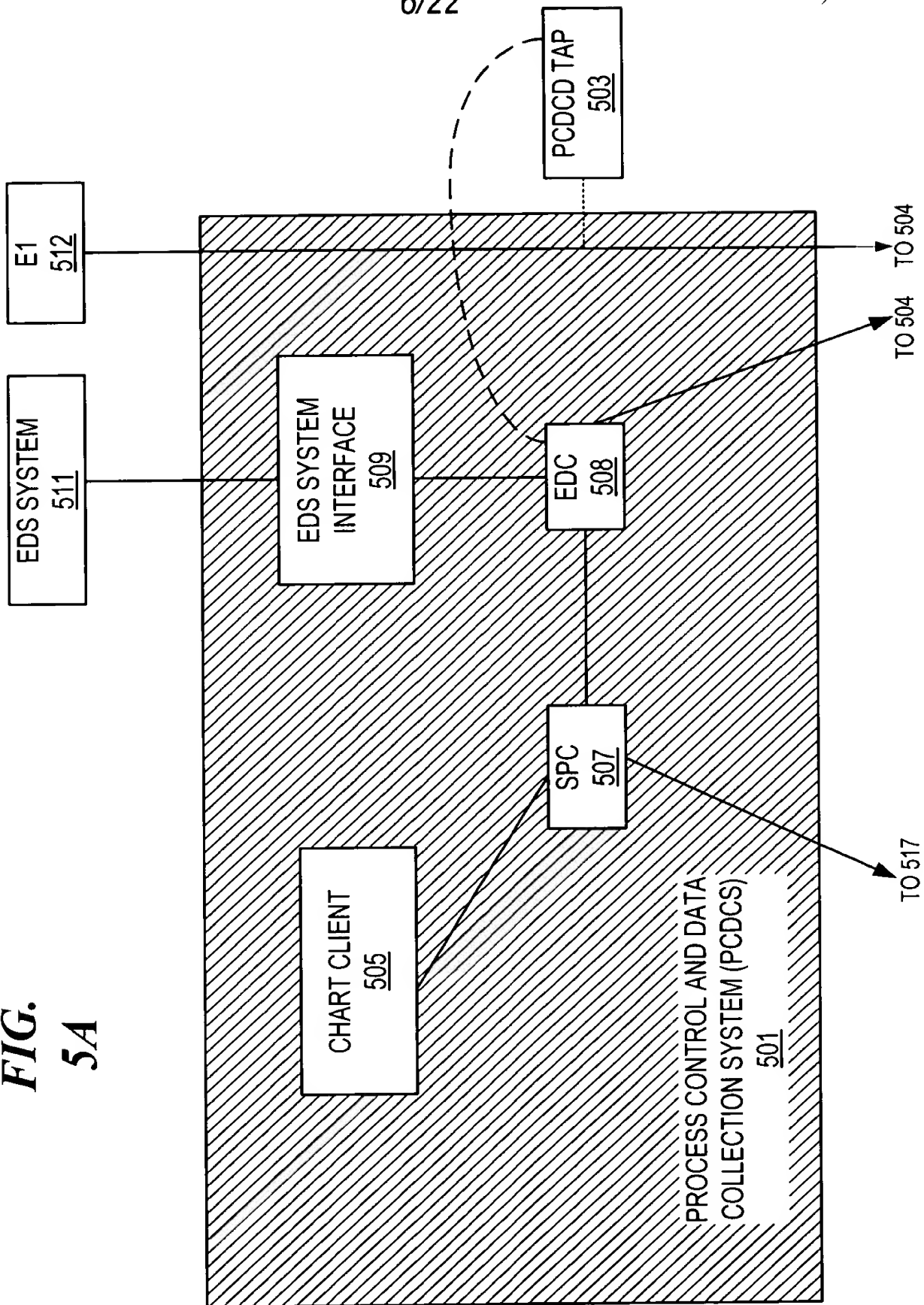
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**FIG.
5A**





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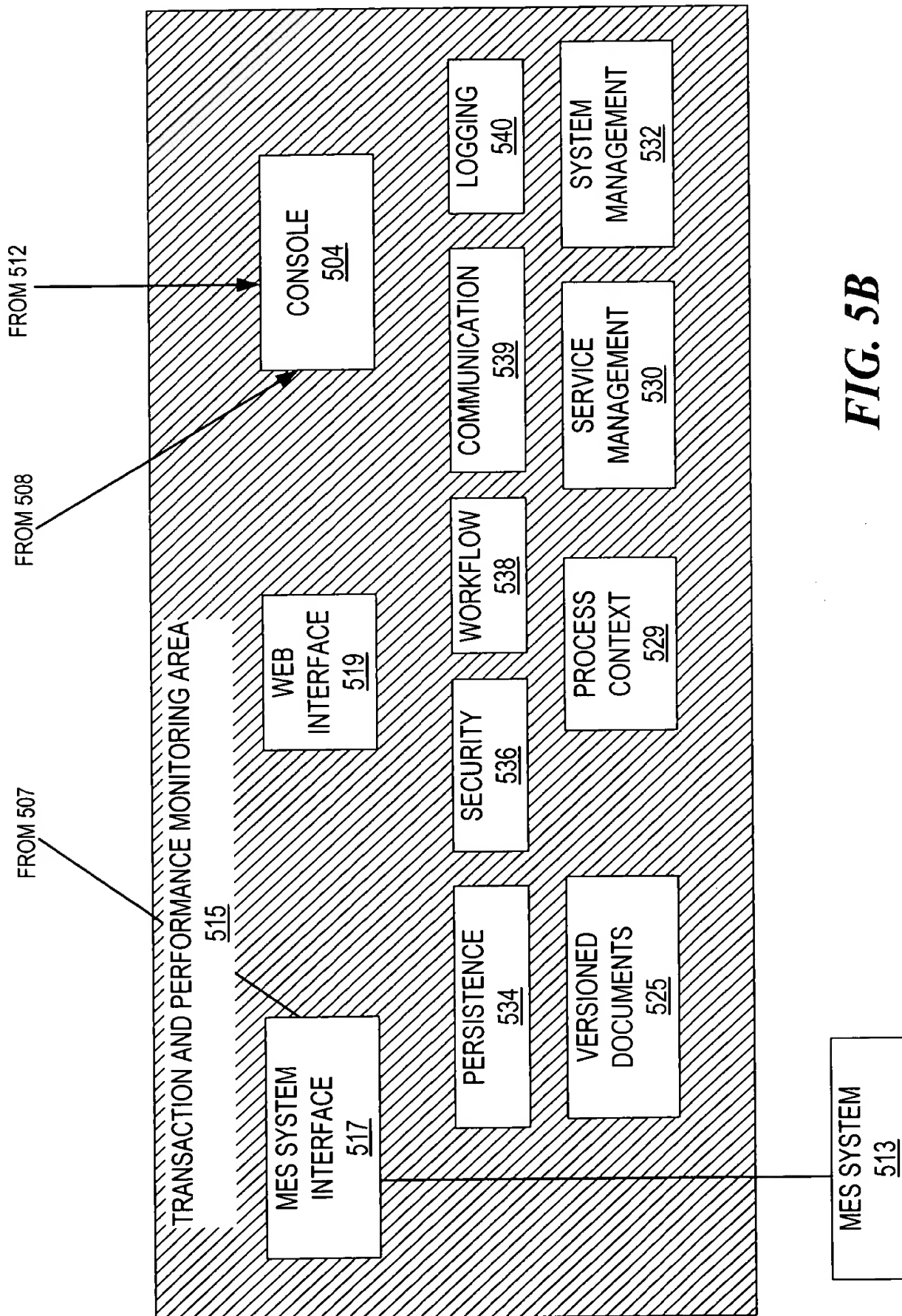


FIG. 5B



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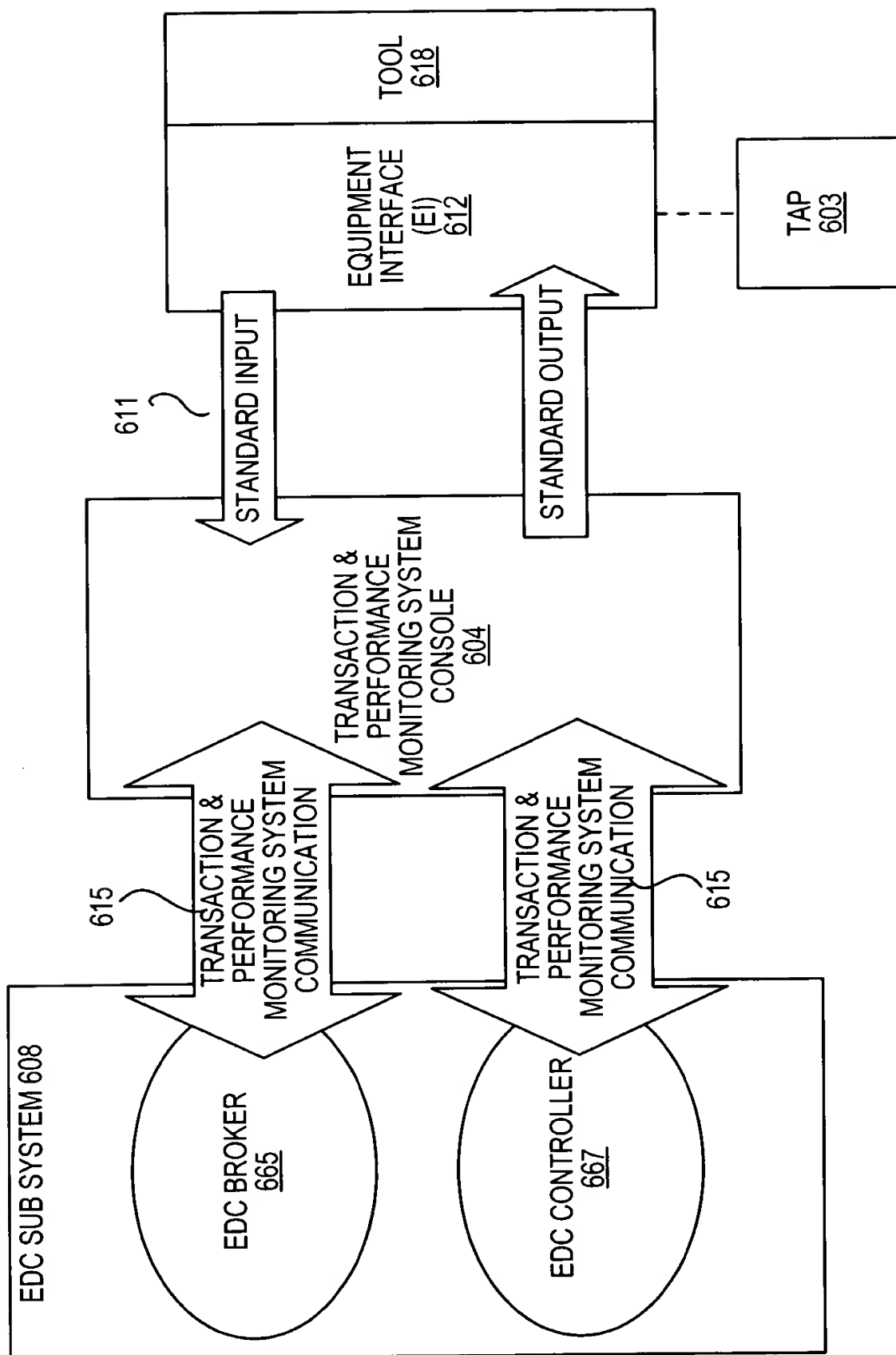


FIG. 6

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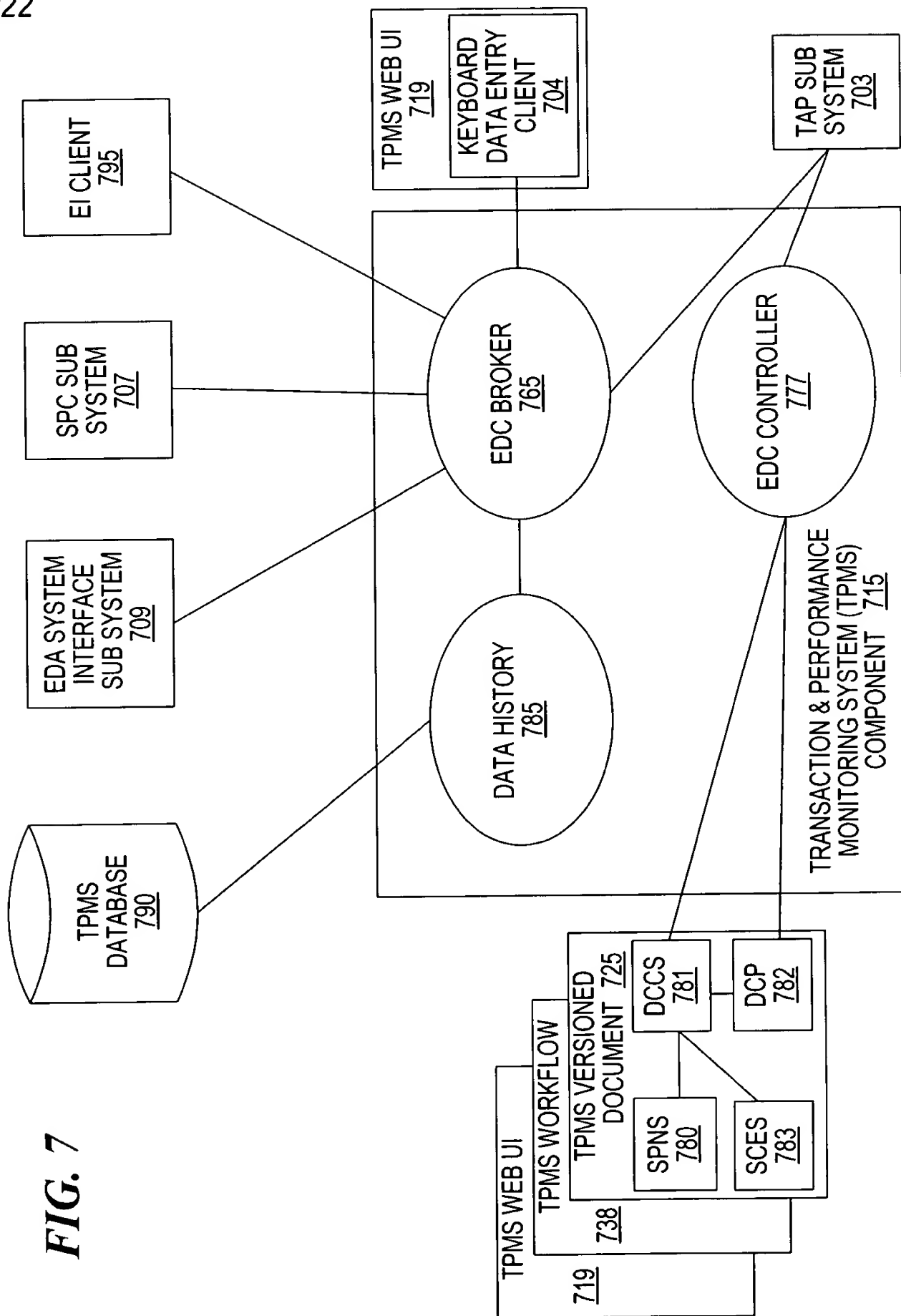


FIG. 7



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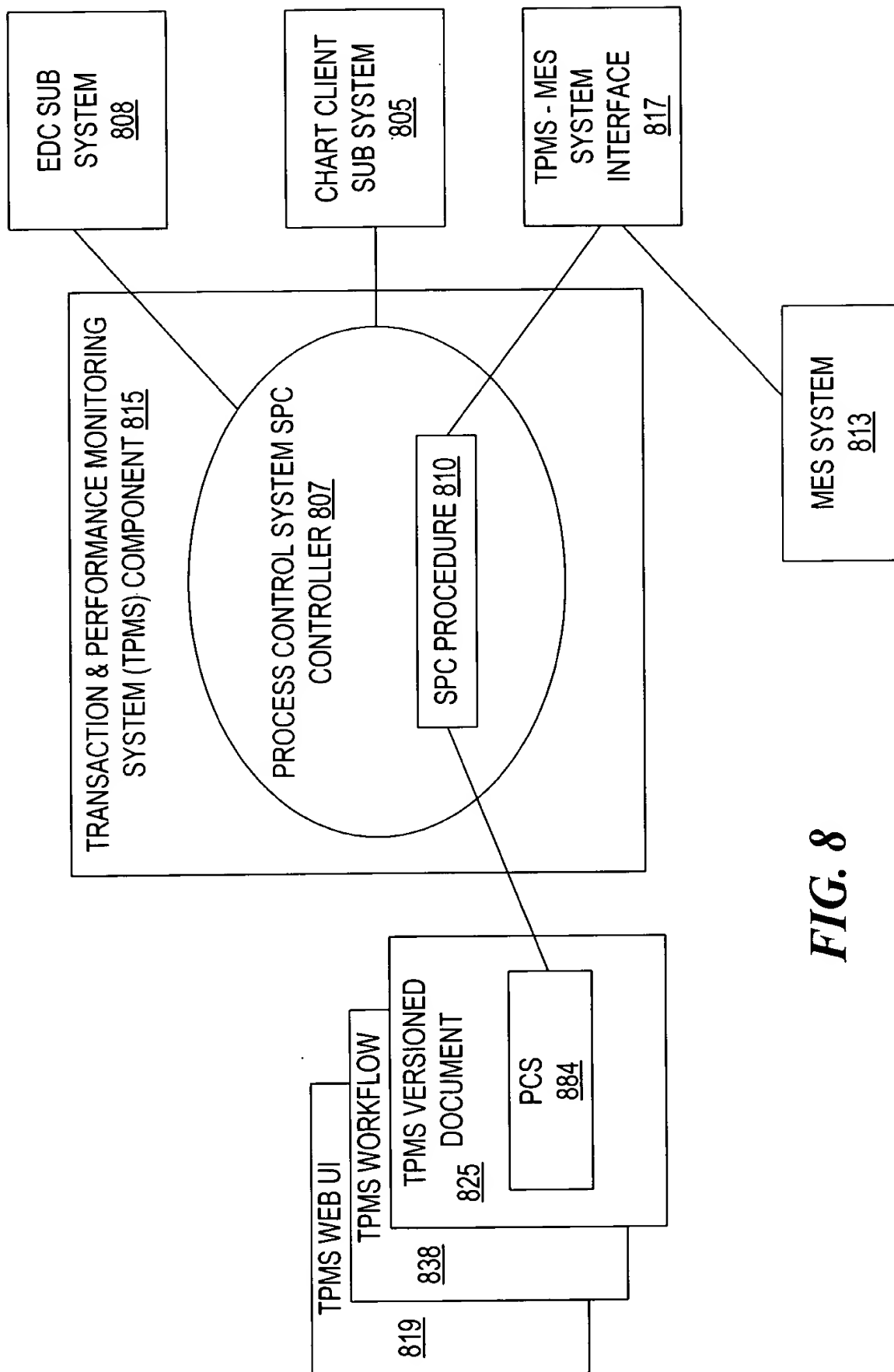


FIG. 8

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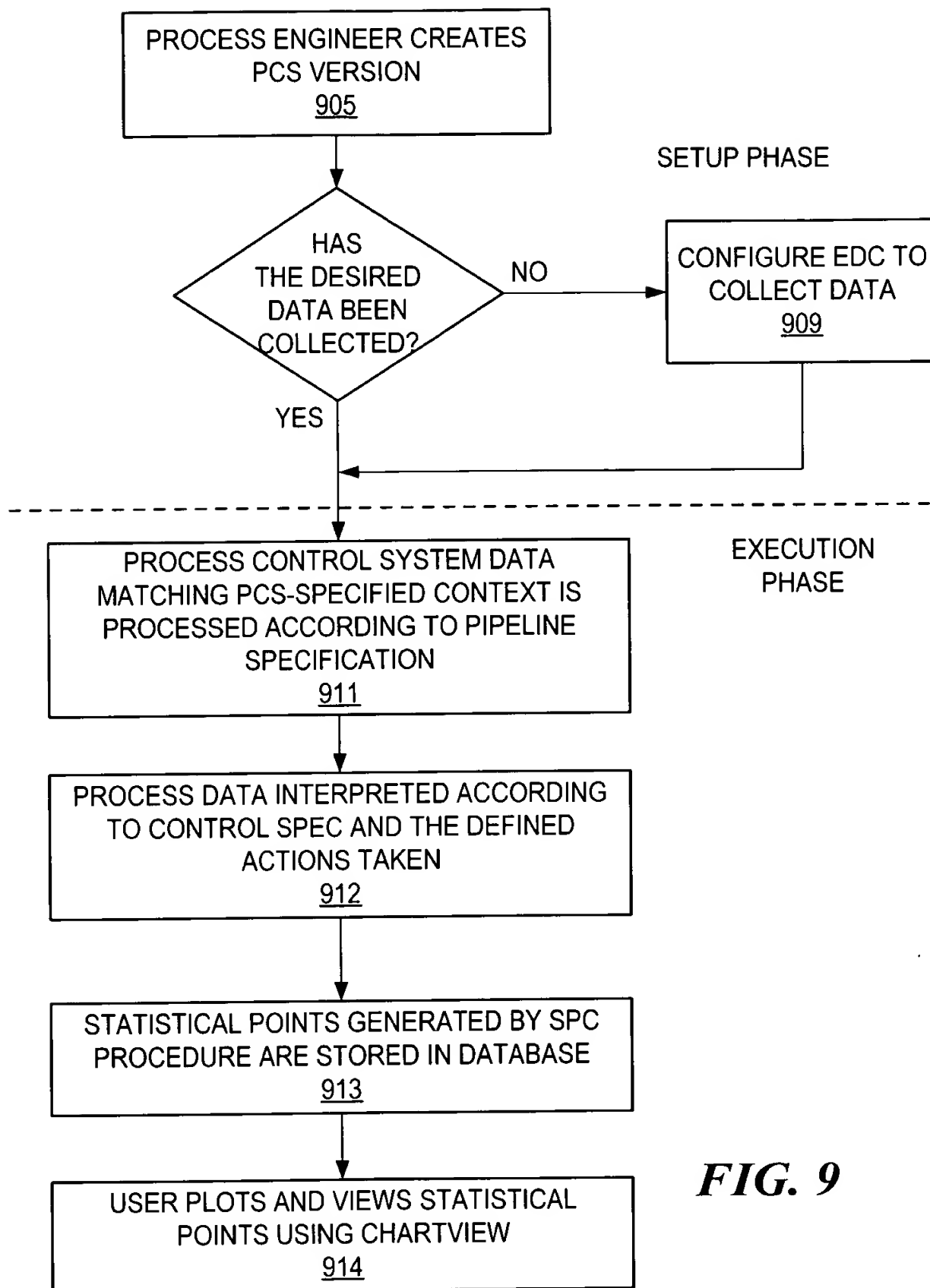


FIG. 9



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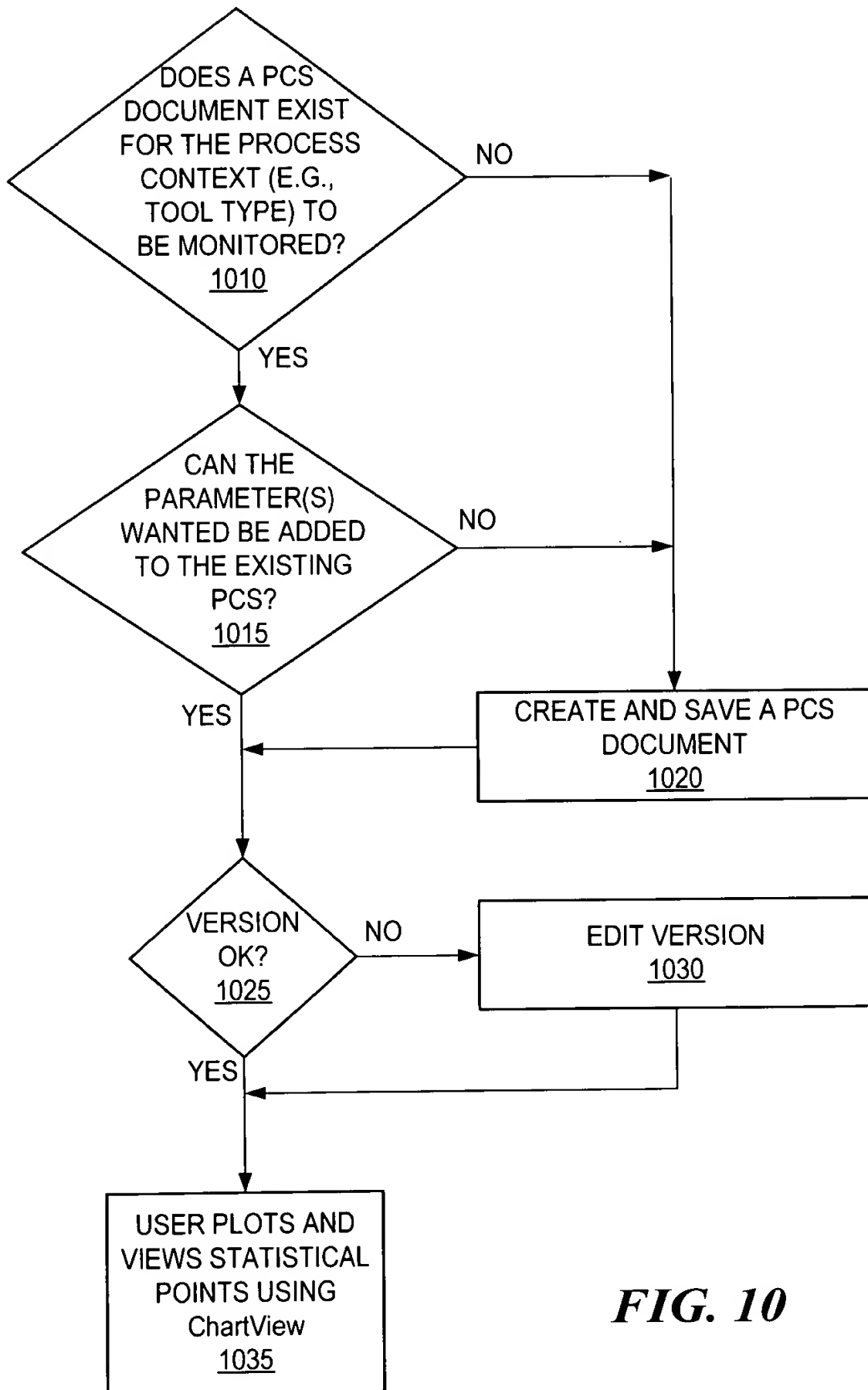


FIG. 10



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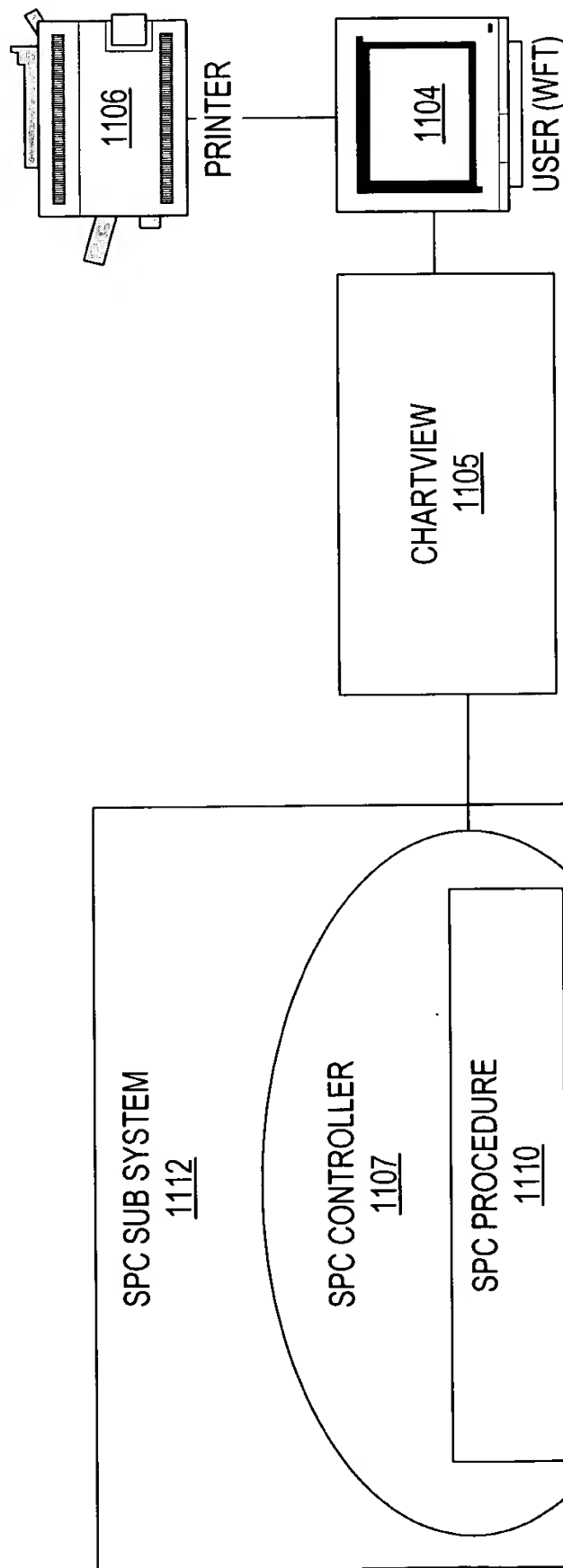
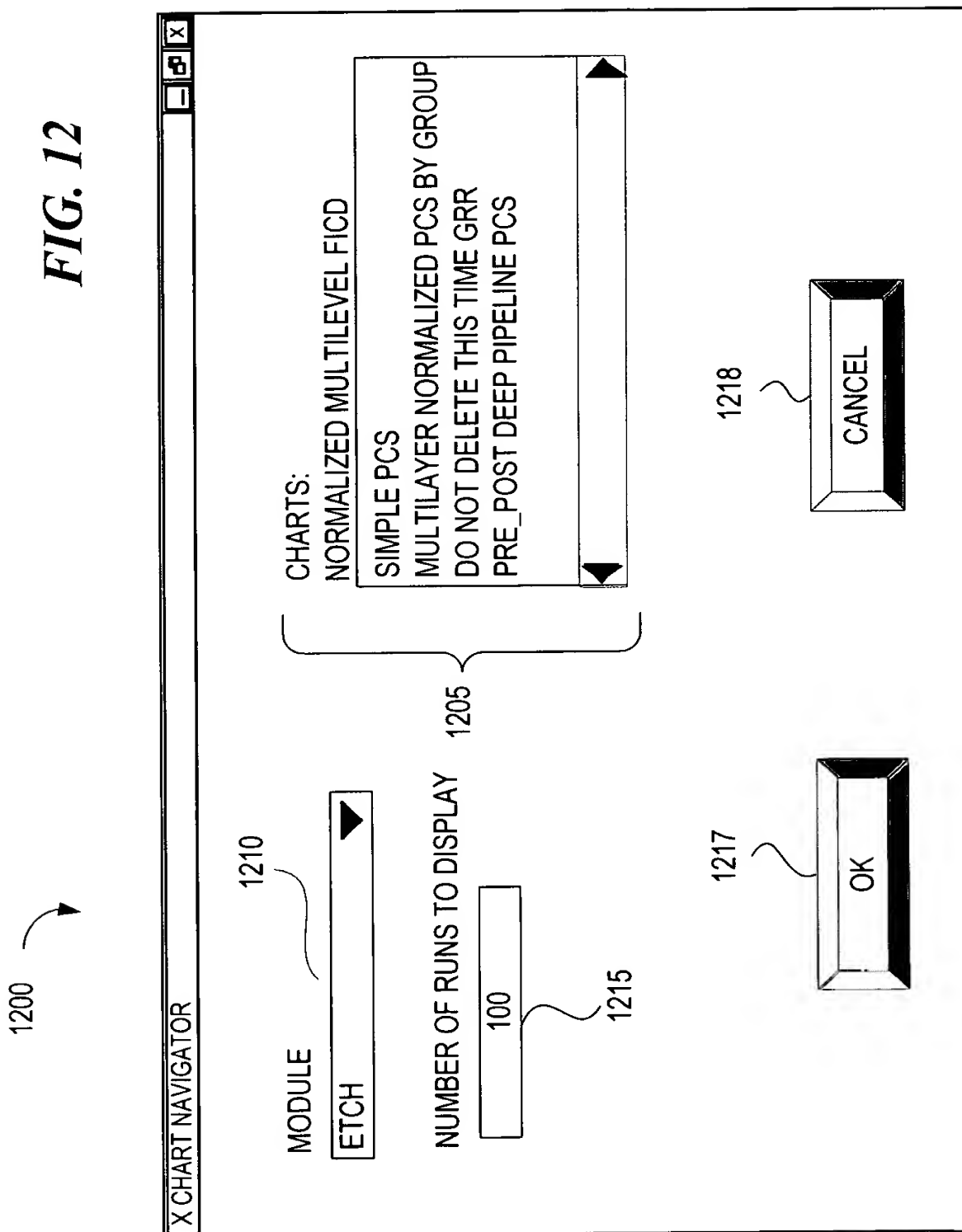


FIG. 11



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FIG. 12



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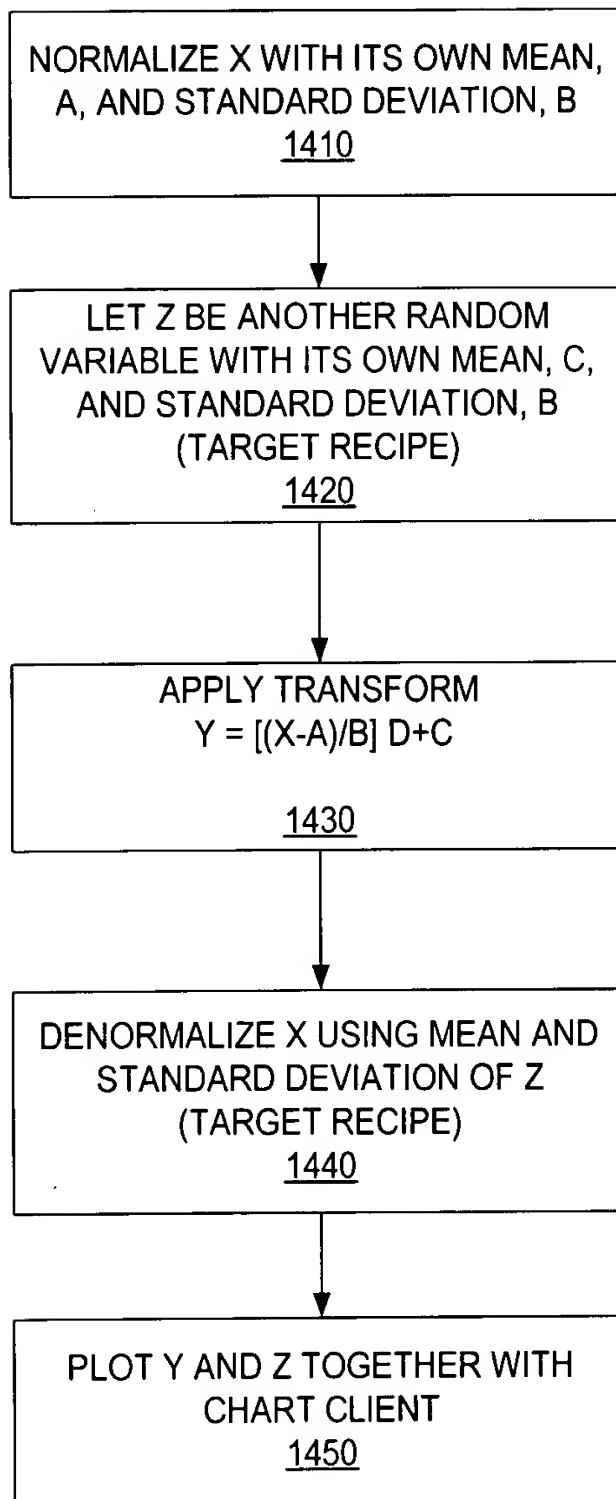


FIG. 14



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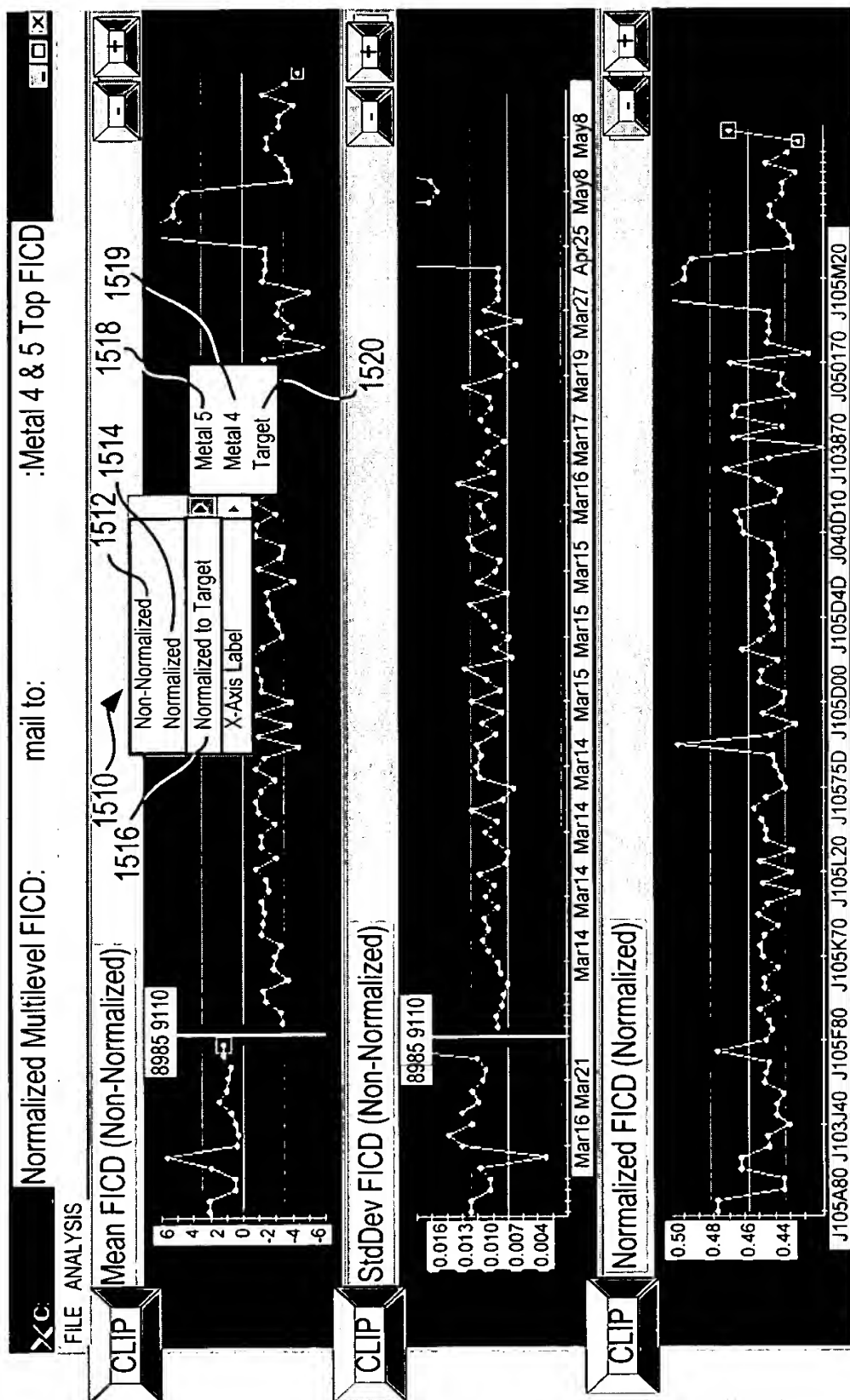


FIG. 15



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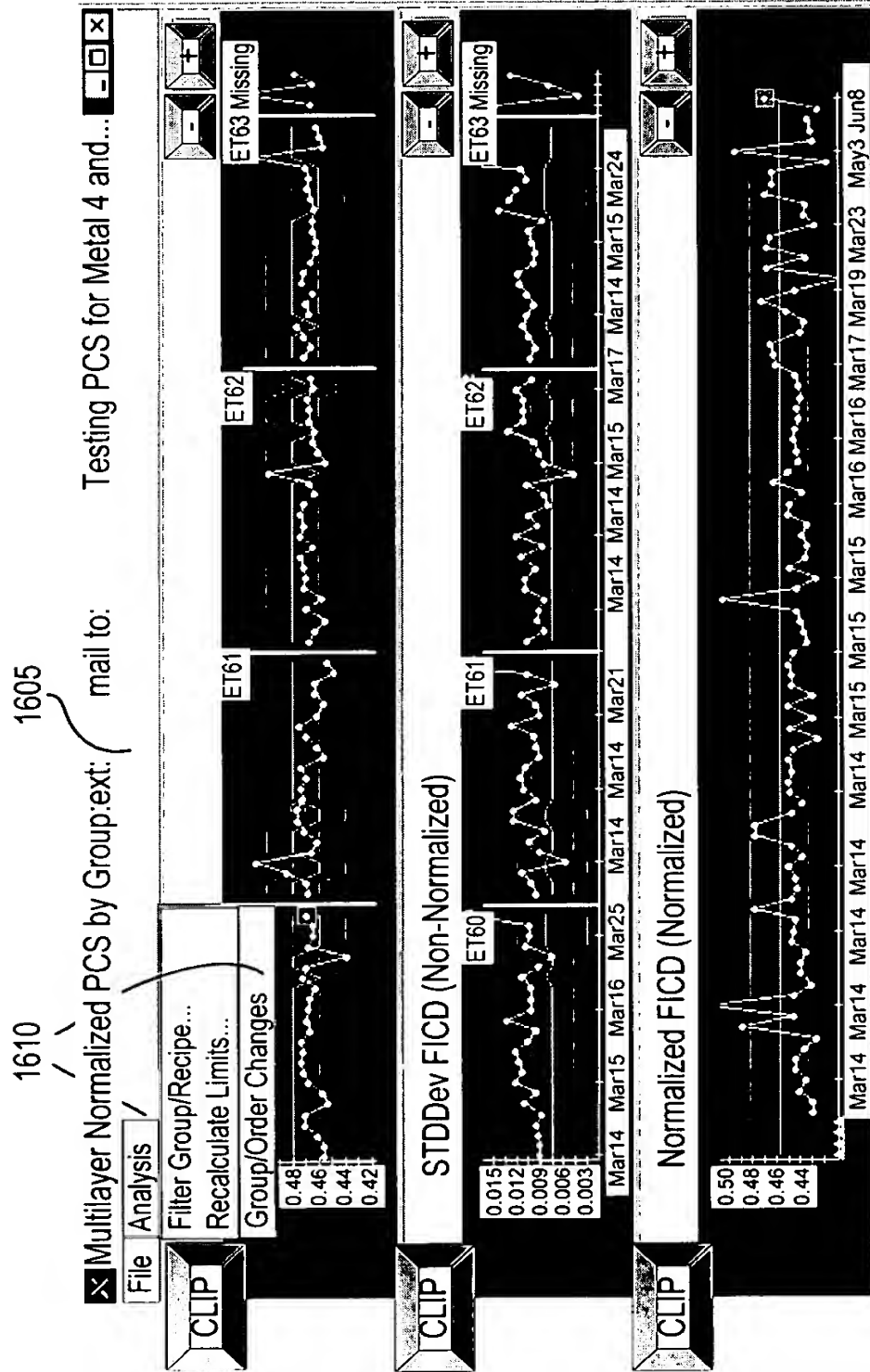


FIG. 16



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X ALTER GROUPING, ORDERING

	1715	1720
1705	STATISTIC	
1706	MEAN FICD	
1707	STDDEV FICD	
1708	NORMALIZED FICD	
	LINKED	
	<input checked="" type="checkbox"/> <input checked="" type="checkbox"/> <input checked="" type="checkbox"/>	
	GROUP BY	ORDER BY
	PROCESS TOOL PROCESS TOOL NONE	PROCESS TIME PROCESS TIME PROCESS TIME

1710

GO 1725

CANCEL 1730

FIG. 17



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FIG. 18

1800

1810

X GRAPHPOINT DETAIL WINDOW

GENERAL INFORMATION SCF

1811

GENERAL

VALUE: 0.524400
UCL: 0.5
TARGET: 0.48
LCL: 0.46
PCS RECIPE: METAL 5
RUNLD: 106537
OOC VIOLATION: ONE OUT ABOVE [WE CONTROL RULES]

ATTRIBUTES	VALUE
LOT	J105M20
OPERATION	9110
PRODUCT	6308AC
MEASUREMENT TIME	2001-04-25 13:32:04
OPAL	C012
BATCH	

OUT-OF-CONTROL ACTIONS

ACTION	CORRECT	MESSAGE
SHUTDOWN TOOL	BRING BACK TOOL	1830
HOLD LOT	RELEASE LOT	
EMAIL		
	1825	

1835

ANNOTATION HISTORY

TIME	CREATOR	ANNOTATION
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1816

1820

DONE

1821

ADD



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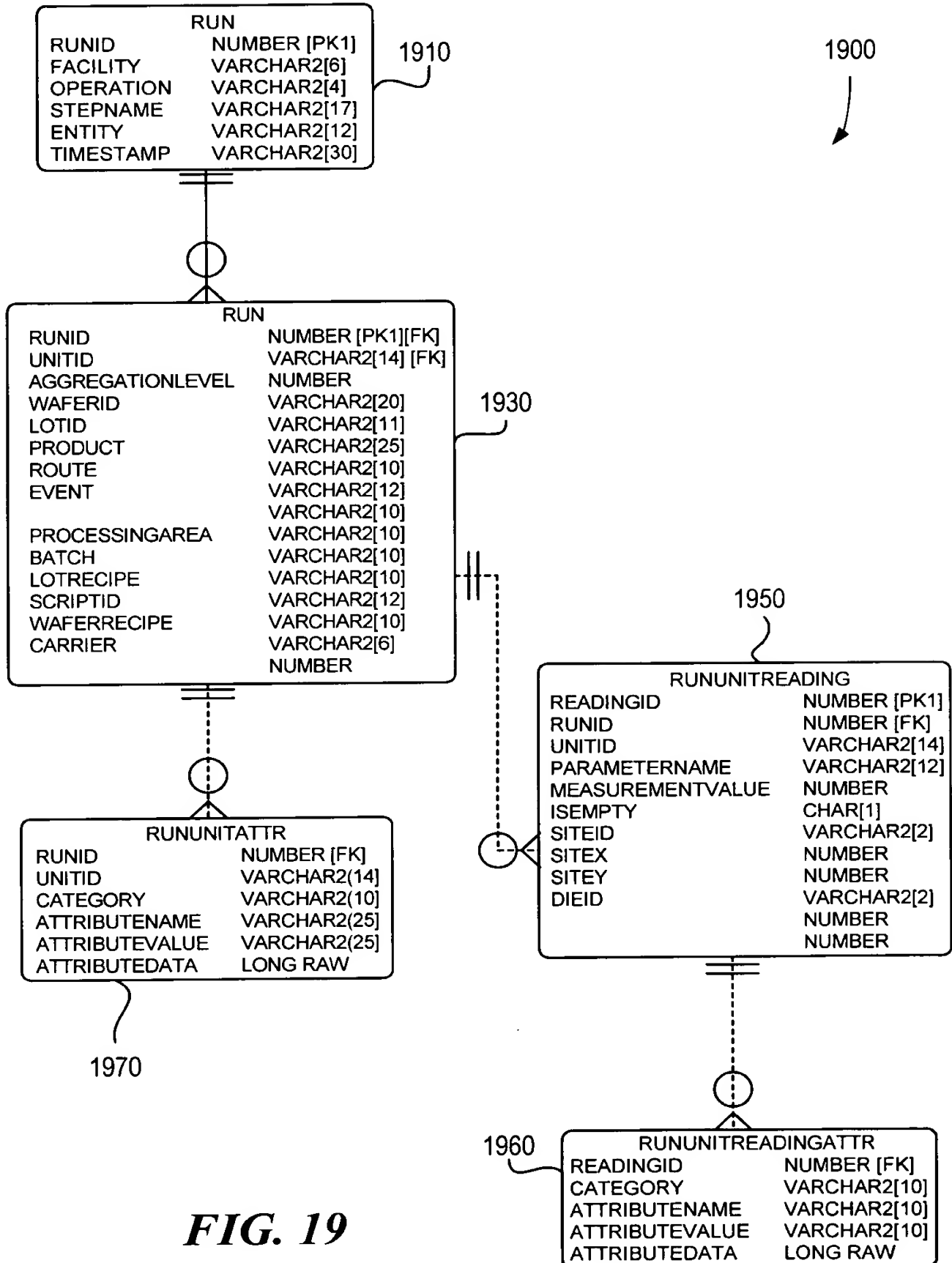


FIG. 19

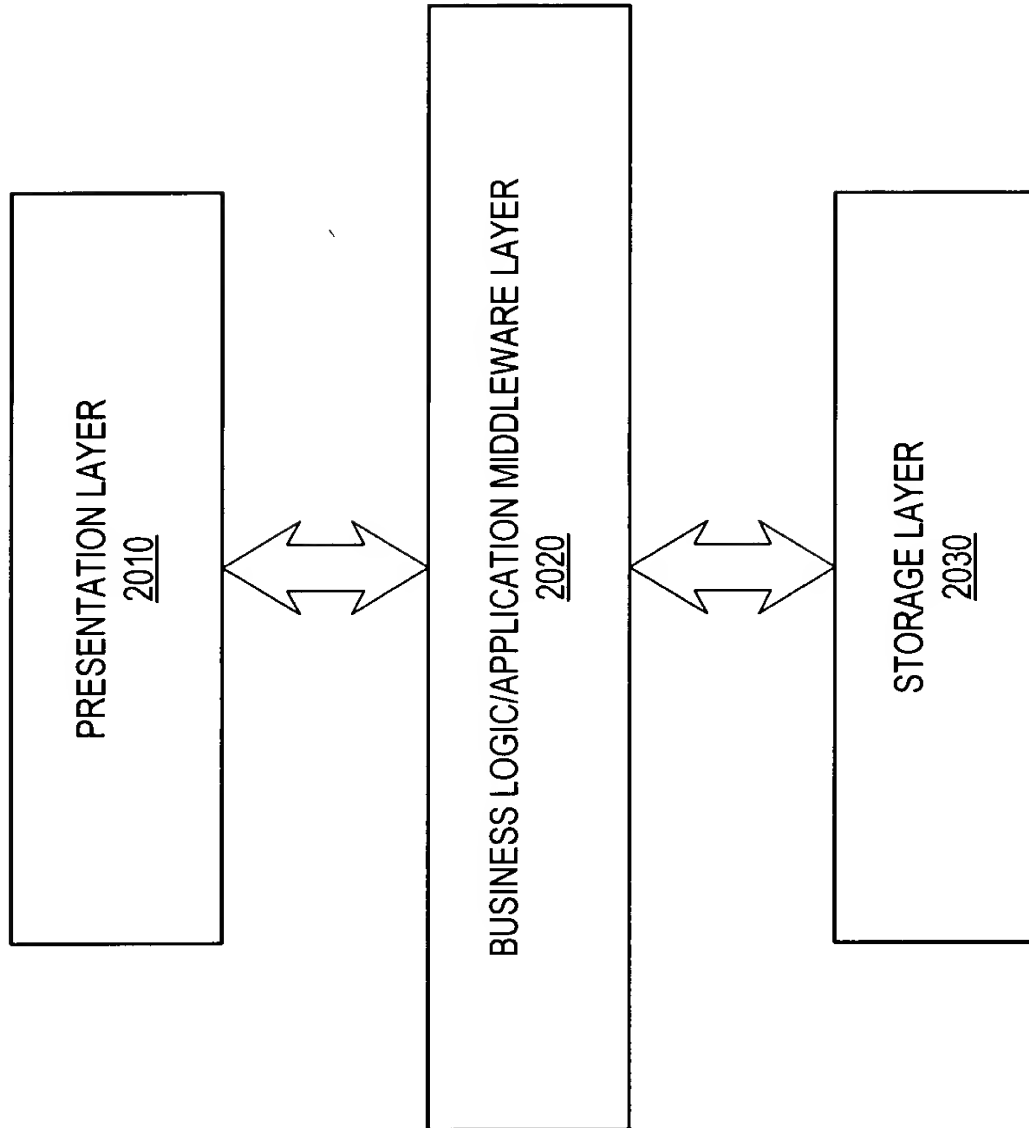


FIG. 20